Search Notes		

Application/Control N	o. Applicant(s)/Patent under Reexamination	
09/759,220	HAYASHI, KEIICHI	
Examiner	Art Unit	
Julio R. Perez	2681	

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	DATE	EXMR
East	2/1/2006	JP
Temika Beamer	2/1/2006	JP
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